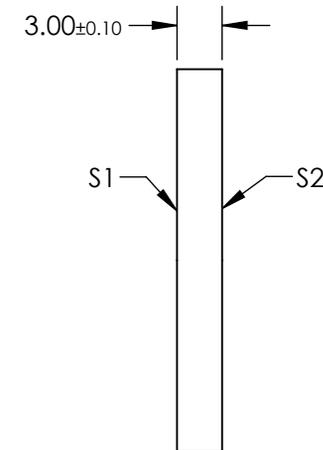
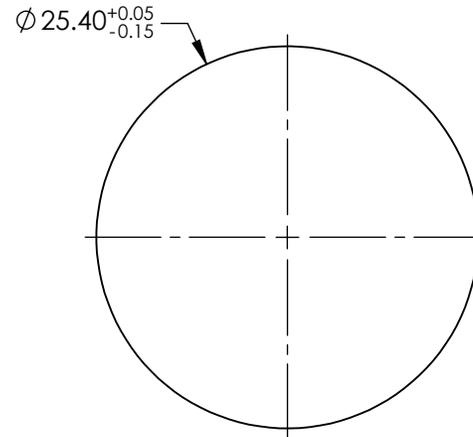


NOTES:

1. SUBSTRATE: FUSED SILICA
2. BEAM MODE: SM OR MM
3. SAMPLED ENERGY: 73
4. SAMPLED ANGLE: 2.0 x 2.0
5. COATING:
LASER V-COAT (532nm)
6. BEAM SPECIFICATION:
MINIMUM BEAM DIAMETER: 0.37mm



**FOR INFORMATION ONLY:
DO NOT MANUFACTURE
PARTS TO THIS DRAWING**

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE
DIMENSIONS ARE FOR REFERENCE ONLY

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	S1	S2	THIRD ANGLE PROJECTION		TITLE	532nm, 25.4mm Dia., 9x9 SPOT MATRIX, DIFFRACTIVE BEAMSPLITTER	
SHAPE	PLANO	PLANO	ALL DIMS IN	mm	DWG NO	14685	SHEET 1 OF 1
MIN CLEAR APERTURE	Ø22.9	Ø22.9					
BEVEL MAX FACE	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED					